TOSHIBA 2SC4682

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL TYPE (PCT PROCESS)

2 S C 4 6 8 2

STROBE FLASH APPLICATIONS

MEDIUM POWER AMPLIFIER APPLICATIONS

Excellent hFE Linearity

: $h_{FE(1)} = 800 \sim 3200 \text{ (V}_{CE} = 1 \text{ V, I}_{C} = 0.5 \text{ A)}$

: $h_{FE(2)} = 500$ (Typ.) ($V_{CE} = 1 \text{ V}, I_{C} = 3 \text{ A}$)

Low Collector Saturation Voltage

: $V_{CE (sat)} = 0.5V (Max.) (I_{C} = 3 A, I_{B} = 30 mA)$

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT	
Collector-Base Voltage		V_{CBO}	30	V	
Collector-Emitter Voltage		v_{CES}	30	V	
		V_{CEO}	15		
Emitter-Base Voltage		$V_{ m EBO}$	6	V	
Collector Current	DC	$I_{\mathbf{C}}$	3	A	
	Pulse	I _{CP}	6		
Base Current		IB	0.8	A	
Collector Power Dissipation		PC	900	mW	
Junction Temperature		T_{j}	150	°C	
Storage Temperature Range		$T_{ m stg}$	-55~150	°C	

5.1MAX 0.75MAX 1.0MAX XAM8.0 0.6MAX 1. EMITTER COLLECTOR 2. BASE **JEDEC** TO-92MOD **EIAJ TOSHIBA** 2-5J1A

Unit in mm

Weight: 0.36 g

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30 \text{ V}, I_{E} = 0$	<u> </u>	_	1	μ A
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 6 \text{ V}, I_{C} = 0$	_	_	10	μ A
Collector-Emitter Breakdown Voltage	V (BR) CEO	$I_{\mathrm{C}}=10\mathrm{mA},~I_{\mathrm{B}}=0$	15	_	_	V
DC Current Gain	h _{FE (1)}	$V_{CE} = 1 V, I_{C} = 0.5 A$	800	_	3200	
	h _{FE} (2)	$ m V_{CE} = 1~V,~I_{C} = 3~A$	300	500	_	
Collector-Emitter Saturation Voltage	V _{CE} (sat)	$ m I_{C}=3~A,~I_{B}=30~mA$	_	0.25	0.5	V
Base-Emitter Voltage	$V_{ m BE}$	$V_{CE} = 1 \text{ V}, I_{C} = 3 \text{ A}$	_	0.85	1.2	V
Transition Frequency	$ m f_{T}$	$V_{CE} = 1 \text{ V}, I_{C} = 0.5 \text{ A}$	_	150	-	MHz
Collector Output Capacitance	$C_{ m ob}$	$V_{CB} = 10 \text{ V}, I_{E} = 0, f = 1 \text{ MHz}$	_	30	_	рF

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